

<b>Notice of References Cited</b>	Application/Control No. 10/585,097		Applicant(s)/Patent Under Reexamination LEROY ET AL.	
	Examiner JEREMIAH AVERY		Art Unit 2431	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,807,636	10-2004	Hartman et al.	726/14
*	B	US-6,560,774	05-2003	Gordon et al.	717/146
*	C	US-7,305,534	12-2007	Watt et al.	711/163
*	D	US-7,171,539	01-2007	Mansell et al.	711/203
*	E	US-7,149,862	12-2006	Tune et al.	711/163
*	F	US-7,117,284	10-2006	Watt et al.	710/261
*	G	US-6,151,688	11-2000	Wipfel et al.	714/48
*	H	US-6,658,573	12-2003	Bischof et al.	726/16
*	I	US-7,140,549	11-2006	de Jong, Eduard K.	235/492
*	J	US-6,633,984	10-2003	Susser et al.	726/21
*	K	US-7,127,605	10-2006	Montgomery et al.	713/150
*	L	US-2005/0044197	02-2005	Lai, Ray Y.	709/223
*	M	US-2003/0120593	06-2003	Bansal et al.	705/39

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.